

RF Exposure Evaluation

FCC ID: 2AVAA-XN002

1. Client Information

Applicant : Shenzhen Double New Technology Co.,Ltd
Address : 301B, No.13, phase I, zone 3, Xinhe community, Fuhai street, Bao'an District, Shenzhen, China
Manufacturer : Shenzhen Double New Technology Co.,Ltd
Address : 301B, No.13, phase I, zone 3, Xinhe community, Fuhai street, Bao'an District, Shenzhen, China

2. General Description of EUT

EUT Name	:	Micro laser engraving machine	
Models No.	:	XN002,XN003,XN004,XN005,XN006,XN007,XN008	
Model Difference	:	All these models are in the same PCB, layout and electrical circuit, the only difference is color.	
Product Description	:	Operation Frequency:	Bluetooth V4.1: 2402~2480 MHz
	:	Antenna Gain:	1.5dBi PCB Antenna
Power Supply	:	DC Voltage Supply from AC/DC Adapter.	
Power Rating	:	AC/DC Adapter 1: GQ12-050200-ZU Input: 100~240V/50~60Hz 0.4A Output: 5V 2A	
	:	AC/DC Adapter 2:GQ24-120200-AU Input: 100~240V/50~60Hz 1.0A Output: 12V 2.0A	
Software Version	:	V1.0	
Hardware Version	:	V1.8	
Connecting I/O Port(S)	:	Please refer to the User's Manual	
Remark	:	The antenna gain provided by the applicant, the verified for the RF conduction test provided by TOBY test lab.	

Note: More test information about the EUT please refer the RF Test Report.

SAR Test Exclusion Calculations

1. FCC: According to KDB 447498 D01 Mobile and Portable Devices RF Exposure Procedures and Equipment Authorization Policies v06.

- (1) Clause 4.3: General SAR test reduction and exclusion guidance

- Sub clause 4.31: Standalone SAR test exclusion considerations

- 1) The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6GHz at test separation distance ≤ 5 mm are determined by:

- $$\frac{[(\text{max. power of channel, including tune-up tolerance, mW})/(\text{min. test separation, mm})] * [\sqrt{f_{\text{(GHz)}}}] \leq 3.0 \text{ for 1-g SAR}$$

- $$\frac{[(\text{max. power of channel, including tune-up tolerance, mW})/(\text{min. test separation, mm})] * [\sqrt{f_{\text{(GHz)}}}] \leq 7.5.0 \text{ for 10-g SAR}$$

2. Calculation:

Test separation: 5mm						
Bluetooth Mode (GFSK)						
Frequency (GHz)	Conducted Power (dBm)	Turn-up Power Tolerance (dB)	Max power of tune up tolerance (dbm)	Max power of tune up tolerance (mw)	Calculation Value	Threshold Value
2.402	-0.796	-1 ± 1	0	1.00	0.30997	3.0
2.441	-0.650	-1 ± 1	0	1.00	0.31247	3.0
2.480	-1.001	-1 ± 1	0	1.00	0.31496	3.0
Bluetooth Mode (Pi/4-DQPSK)						
Frequency (GHz)	Conducted Power (dBm)	Turn-up Power Tolerance (dB)	Max power of tune up tolerance (dbm)	Max power of tune up tolerance (mw)	Calculation Value	Threshold Value
2.402	-1.286	-1 ± 1	0	1.00	0.30997	3.0
2.441	-1.016	-1 ± 1	0	1.00	0.31247	3.0
2.480	-1.372	-1 ± 1	0	1.00	0.31496	3.0
Bluetooth Mode (8-DPSK)						
Frequency (GHz)	Conducted Power (dBm)	Turn-up Power Tolerance (dB)	Max power of tune up tolerance (dbm)	Max power of tune up tolerance (mw)	Calculation Value	Threshold Value
2.402	-0.948	-1 ± 1	0	1.00	0.30997	3.0
2.441	-0.648	-1 ± 1	0	1.00	0.31247	3.0
2.480	-1.026	-1 ± 1	0	1.00	0.31496	3.0

Test separation: 5mm						
BLE Mode (GFSK)						
Frequency (GHz)	Conducted Power (dBm)	Turn-up Power Tolerance (dB)	Max power of tune up tolerance (dBm)	Max power of tune up tolerance (mw)	Calculation Value	Threshold Value
2.402	-0.911	-1 ± 1	0	1.00	0.310	3.0
2.442	-0.659	-1 ± 1	0	1.00	0.313	3.0
2.480	-1.051	-1 ± 1	0	1.00	0.315	3.0

So the worst RF Exposure Evaluation is calculated as **0.315 < limit 3.0**.

The measurement results comply with the FCC Limit per 47 CFR 2.1093 for the uncontrolled RF Exposure and SAR Exclusion Threshold per KDB 447498 v06.

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